Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from,Europe,America and south Asia,supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!

Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832
Email & Skype: info@chipsmall.com Web: www.chipsmall.com
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China

NTHD3102C

Power MOSFET
Complementary, 20 V, +5.5 A /–4.2 A, ChipFET™

Features

- Complementary N–Channel and P–Channel MOSFET
- Small Size, 40% Smaller than TSOP–6 Package
- Leadless SMD Package Provides Great Thermal Characteristics
- Leading Edge Trench Technology for Low On Resistance
- Reduced Gate Charge to Improve Switching Response
- This is a Pb–Free Device

Applications

- DC–DC Conversion Circuits
- Load/Power Switching
- Single or Dual Cell Li–Ion Battery Supplied Devices
- Ideal for Power Management Applications in Portable, Battery Powered Products

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain–to–Source Voltage			V_{DSS}	20	V
Gate–to–Source Voltage	N–Ch		V_{GS}	±8.0	V
	P–Ch			±8.0	
N–Channel Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	4.0	A
		T_A = 85°C		2.9	
	t ≤ 5 s	T_A = 25°C		5.5	
P–Channel Continuous Drain Current (Note 1)	Steady State	T_A = 25°C	I_D	3.1	A
		T_A = 85°C		2.2	
	t ≤ 5 s	T_A = 25°C		4.2	
Power Dissipation (Note 1)	Steady State	T_A = 25°C	P_D	1.1	W
	t ≤ 5 s			2.1	
Gate–to–Source ESD Rating – (Human Body Model, Method 3015)			ESD	100	V

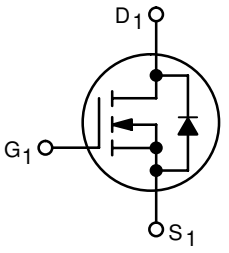
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface–mounted on FR4 board using 1 in sq pad size (Cu. area = 1.127 in sq [1 oz] including traces).

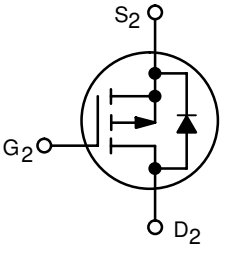
ON Semiconductor®

http://onsemi.com

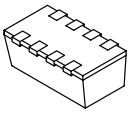
$V_{(BR)DSS}$	$R_{DS(on)}$ TYP	I_D MAX (Note 1)
N–Channel 20 V	29 mΩ @ 4.5 V	5.5 A
	37 mΩ @ 2.5 V	
	48 mΩ @ 1.8 V	
P–Channel –20 V	64 mΩ @ 4.5 V	–4.2 A
	83 mΩ @ 2.5 V	
	105 mΩ @ 1.8 V	



N–Channel MOSFET

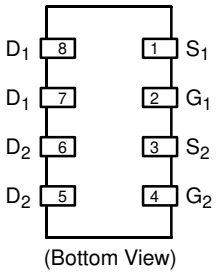


P–Channel MOSFET



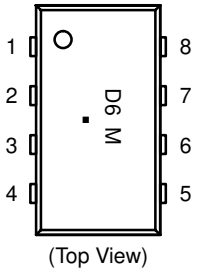
ChipFET
CASE 1206A
STYLE 2

PIN CONNECTIONS



(Bottom View)

MARKING DIAGRAM



(Top View)

D6 = Specific Device Code
M = Date Code
▪ = Pb–Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

MAXIMUM RATINGS (continued) (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
N−Channel Continuous Drain Current (Note 3)	Steady State	T_A = 25°C	I_D	3.0	A
		T_A = 85°C		2.2	
P−Channel Continuous Drain Current (Note 3)	Steady State	T_A = 25°C	I_D	2.3	A
		T_A = 85°C		1.7	
Power Dissipation (Note 3)		T_A = 25°C	P_D	0.6	W
Pulsed Drain Current	N−Ch	tp = 10 μs	I_{DM}	16	A
	P−Ch			12.6	
Operating Junction and Storage Temperature			T_J, T_{STG}	−55 to 150	°C
Source Current (Body Diode)			I_S	1.7	A
Lead Temperature for Soldering Purposes (1/8″ from case for 10 seconds)			T_L	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction−to−Ambient − Steady State (Note 2)	$R_{\theta JA}$	110	°C/W
Junction−to−Ambient − t ≤ 5 s (Note 2)		60	
Junction−to−Ambient − Steady State (Note 3)		195	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	N/P	Test Conditions		Min	Typ	Max	Unit
OFF CHARACTERISTICS								
Drain−to−Source Breakdown Voltage (Note 4)	$V_{(BR)DSS}$	N	V_{GS} = 0 V	I_D = 250 μA	20			V
		P		I_D = −250 μA	−20			
Drain−to−Source Breakdown Voltage Temperature Coefficient	$V_{(BR)DSS}/T_J$	N				20.2		mV/°C
		P				16.2		
Zero Gate Voltage Drain Current	I_{DSS}	N	V_{GS} = 0 V, V_{DS} = 16 V	T_J = 25 °C			1.0	μA
		P	V_{GS} = 0 V, V_{DS} = −16 V				−1.0	
		N	V_{GS} = 0 V, V_{DS} = 16 V	T_J = 85 °C			5.0	
		P	V_{GS} = 0 V, V_{DS} = −16 V				−5.0	
Gate−to−Source Leakage Current	I_{GSS}	N	V_{DS} = 0 V, V_{GS} = ±8.0 V				±100	nA
		P	V_{DS} = 0 V, V_{GS} = ±8.0 V				±100	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

2. Surface−mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
3. Surface−mounted on FR4 board using the minimum recommended pad size (Cu area = TBD in sq).
4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (continued) (T_J = 25°C unless otherwise noted)

Parameter	Symbol	N/P	Test Conditions		Min	Typ	Max	Unit
ON CHARACTERISTICS (Note 5)								
Gate Threshold Voltage	$V_{GS(TH)}$	N	$V_{GS} = V_{DS}$	I_D = 250 μA	0.4		1.2	V
		P		I_D = –250 μA	–0.4		–1.2	
Drain–to–Source On Resistance	$R_{DS(on)}$	N	V_{GS} = 4.5 V , I_D = 4.4 A			29	45	mΩ
		P	V_{GS} = –4.5 V , I_D = –3.2 A			64	80	
		N	V_{GS} = 2.5 V , I_D = 4.1 A			37	50	
		P	V_{GS} = –2.5 V, I_D = –2.5 A			83	110	
		N	V_{GS} = 1.8 V , I_D = 1.9 A			48	70	
		P	V_{GS} = –1.8 V, I_D = –0.6 A			105	150	
Forward Transconductance	g_{FS}	N	V_{DS} = 10 V, I_D = 4.4 A			7.7		S
		P	V_{DS} = –10 V , I_D = –3.2 A			5.9		
CHARGES, CAPACITANCES AND GATE RESISTANCE								
Input Capacitance	C_{ISS}	N	f = 1.0 MHz, V_{GS} = 0 V	V_{DS} = 10 V		510		pF
		P		V_{DS} = –10 V		650		
Output Capacitance	C_{OSS}	N		V_{DS} = 10 V		100		
		P		V_{DS} = –10 V		100		
Reverse Transfer Capacitance	C_{RSS}	N		V_{DS} = 10 V		50		
		P		V_{DS} = –10 V		50		
Total Gate Charge	$Q_{G(TOT)}$	N	V_{GS} = 4.5 V, V_{DS} = 10 V, I_D = 4.4 A			5.8	7.9	nC
		P	V_{GS} = –4.5 V, V_{DS} = –10 V, I_D = –3.2 A			6.6	8.9	
Threshold Gate Charge	$Q_{G(TH)}$	N	V_{GS} = 4.5 V, V_{DS} = 10 V, I_D = 4.4 A			0.96		
		P	V_{GS} = –4.5 V, V_{DS} = –10 V, I_D = –3.2 A			0.98		
Gate–to–Source Charge	Q_{GS}	N	V_{GS} = 4.5 V, V_{DS} = 10 V, I_D = 4.4 A			1.2		
		P	V_{GS} = –4.5 V, V_{DS} = –10 V, I_D = –3.2 A			1.4		
Gate–to–Drain Charge	Q_{GD}	N	V_{GS} = 4.5 V, V_{DS} = 10 V, I_D = 4.4 A			1.56		
		P	V_{GS} = –4.5 V, V_{DS} = –10 V, I_D = –3.2 A			1.64		
SWITCHING CHARACTERISTICS (Note 6)								
Turn–On Delay Time	$t_{d(ON)}$	N	V_{GS} = 4.5 V, V_{DD} = 10 V, I_D = 4.4 A, R_G = 2.5 Ω			7.2		ns
Rise Time	t_r					15.9		
Turn–Off Delay Time	$t_{d(OFF)}$					15.7		
Fall Time	t_f					4.6		
Turn–On Delay Time	$t_{d(ON)}$	P	V_{GS} = –4.5 V, V_{DD} = –10 V, I_D = –3.2 A, R_G = 2.5 Ω			6.4		
Rise Time	t_r					16.9		
Turn–Off Delay Time	$t_{d(OFF)}$					16.4		
Fall Time	t_f					15.0		

5. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (continued) (T_J = 25°C unless otherwise noted)

Parameter	Symbol	N/P	Test Conditions		Min	Typ	Max	Unit
DRAIN–SOURCE DIODE CHARACTERISTICS								
Forward Diode Voltage	V_{SD}	N	V_{GS} = 0 V, T_J = 25 °C	I_S = 1.7 A		0.68	1.2	V
		P		I_S = –1.7 A		–0.7	–1.2	
Reverse Recovery Time	t_{RR}	N	V_{GS} = 0 V, dI_S / dt = 100 A/μs	I_S = 1.7 A		13.5		ns
		P		I_S = –1.7 A		12.6		
Charge Time	t_a	N		I_S = 1.7 A		8.6		
		P		I_S = –1.7 A		8.4		
Discharge Time	t_b	N		I_S = 1.7 A		4.9		
		P		I_S = –1.7 A		4.2		
Reverse Recovery Charge	Q_{RR}	N		I_S = 1.7 A		7.0		nC
		P		I_S = –1.7 A		6.0		

TYPICAL N−CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

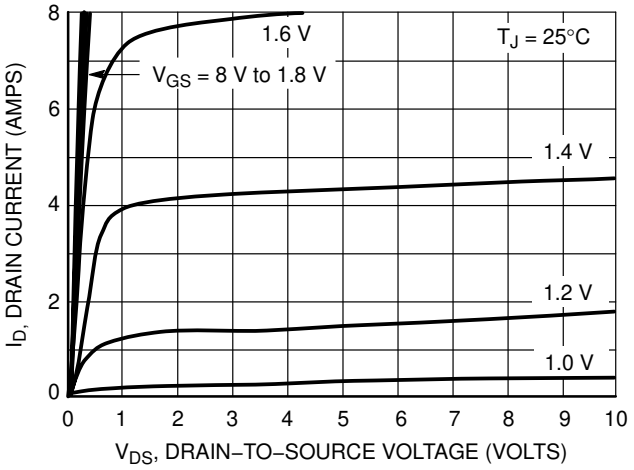


Figure 1. On−Region Characteristics

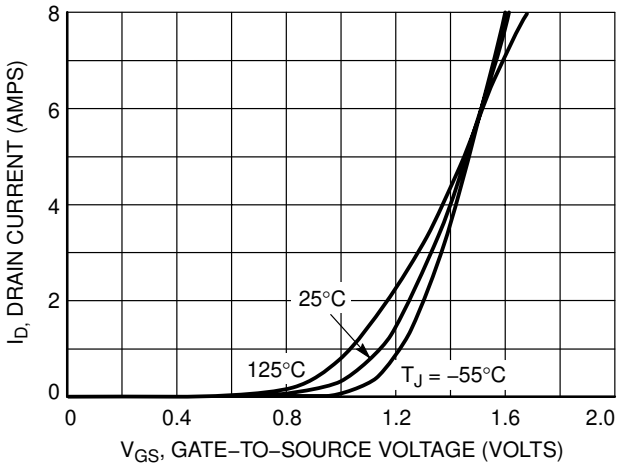


Figure 2. Transfer Characteristics

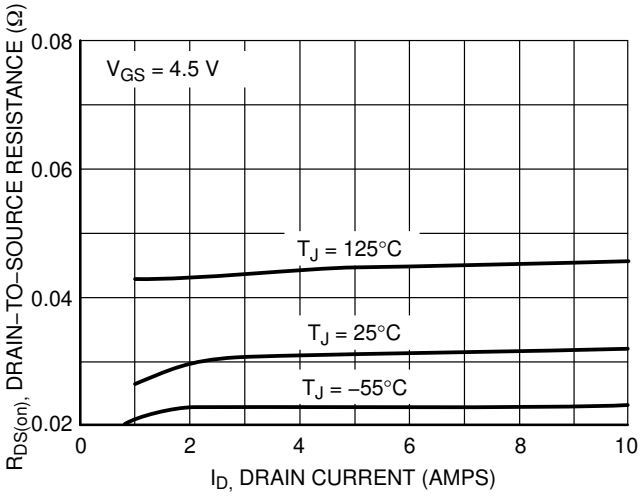


Figure 3. On−Resistance vs. Drain Current

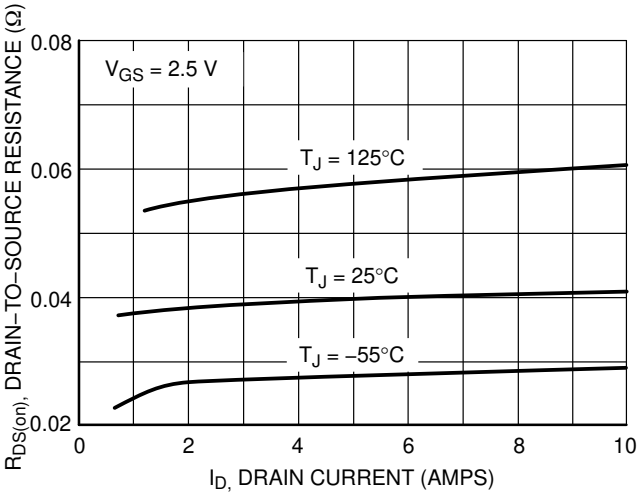


Figure 4. On−Resistance vs. Drain Current and Temperature

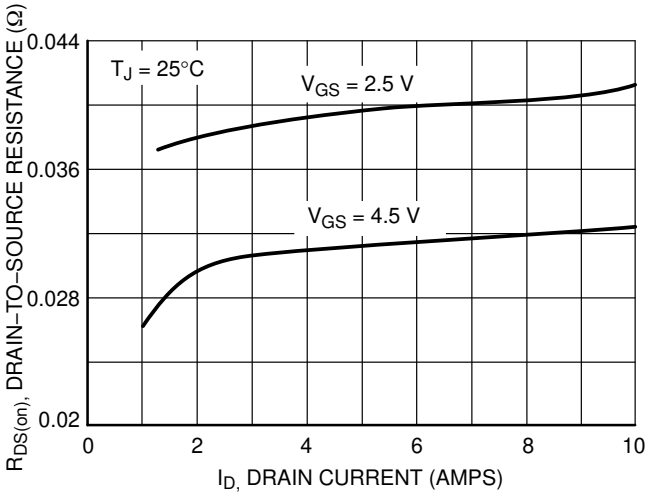


Figure 5. On−Resistance vs. Drain Current

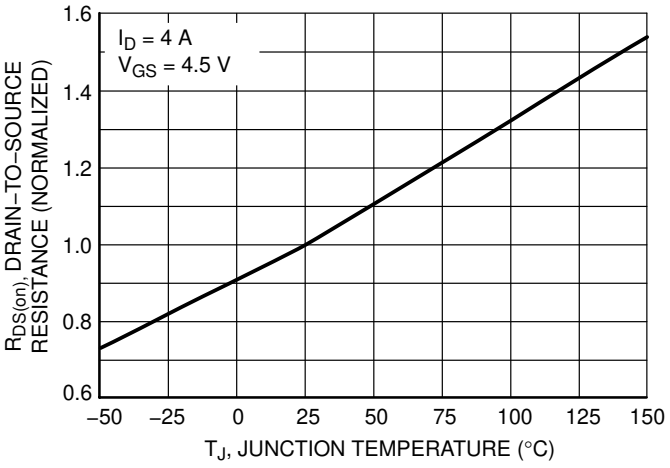


Figure 6. On−Resistance Variation with Temperature

TYPICAL N−CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

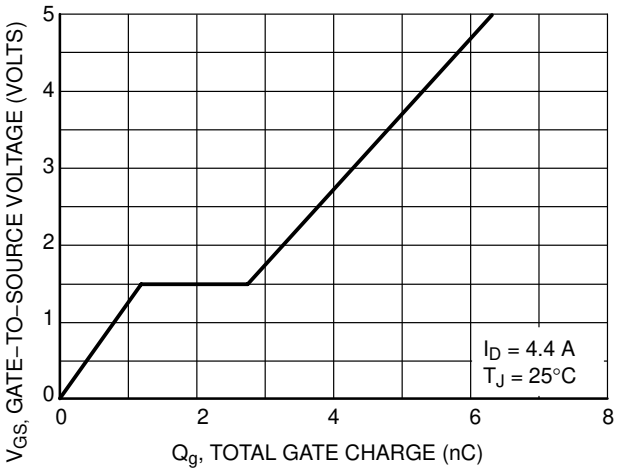


Figure 7. Gate−to−Source and Drain−to−Source Voltage vs. Total Charge

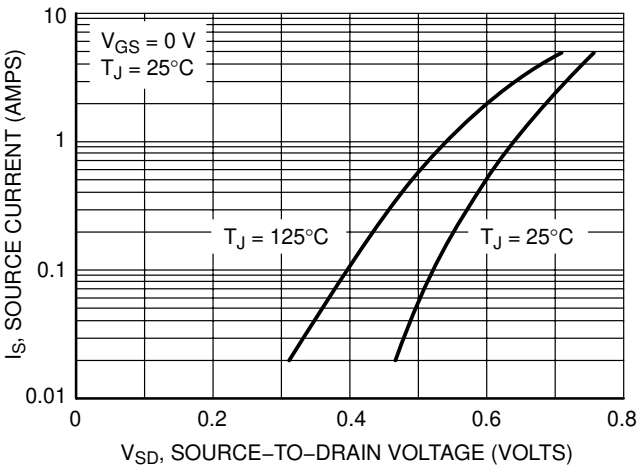


Figure 8. Diode Forward Voltage vs. Current

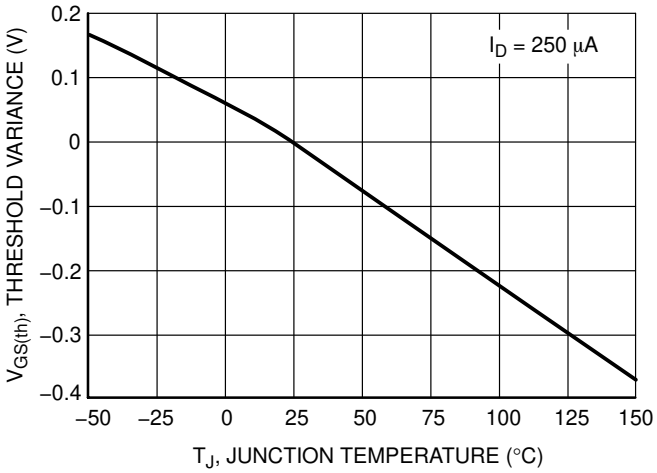


Figure 9. Threshold Voltage

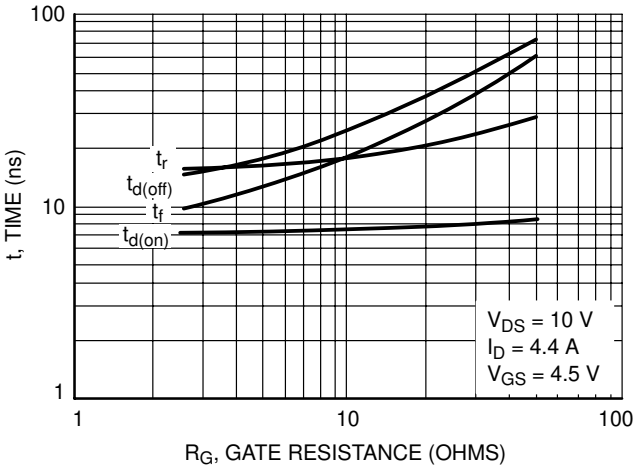


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

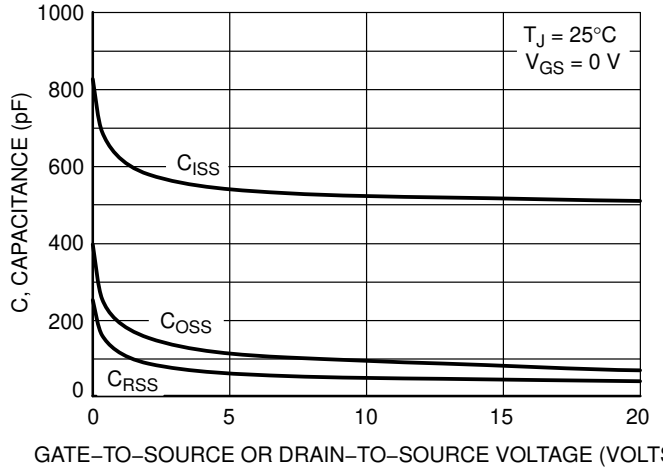


Figure 11. Capacitance Variation

TYPICAL P−CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

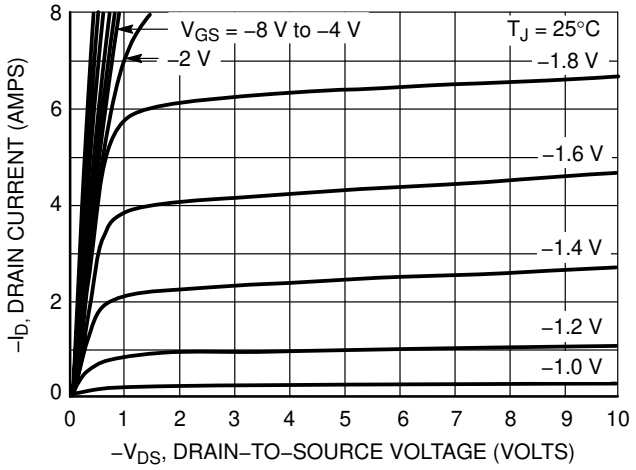


Figure 12. On−Region Characteristics

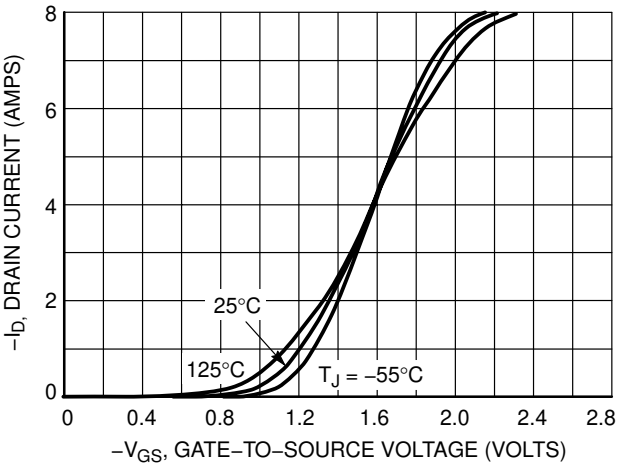


Figure 13. Transfer Characteristics

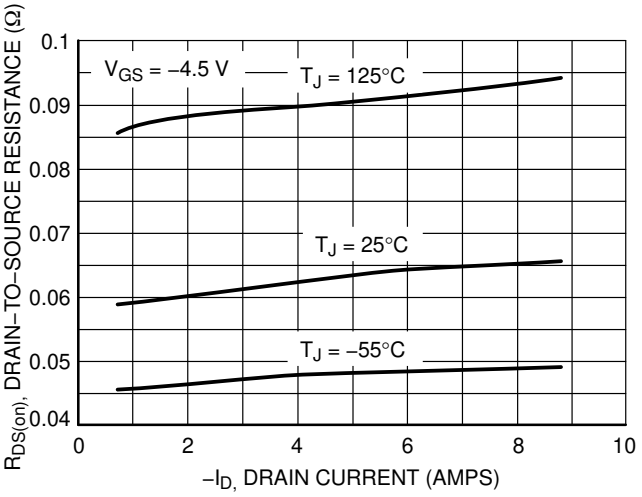


Figure 14. On−Resistance vs. Drain Current

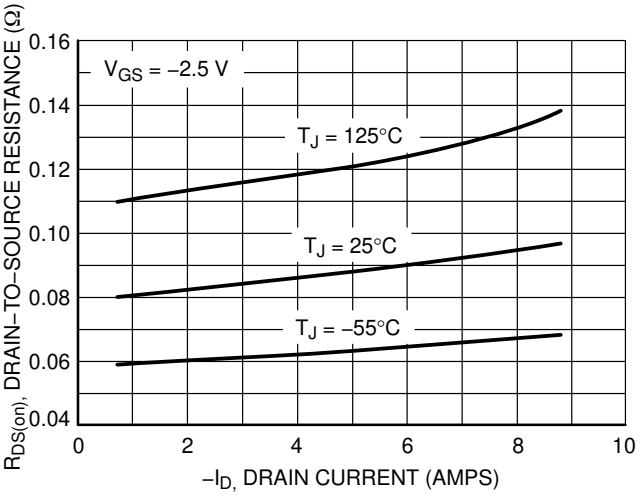


Figure 15. On−Resistance vs. Drain Current and Temperature

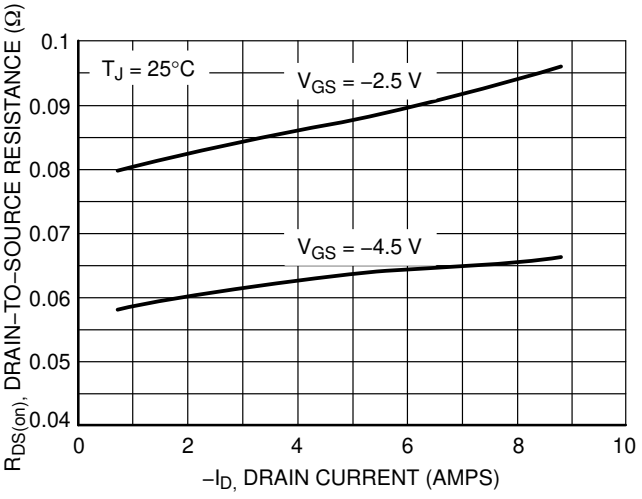


Figure 16. On−Resistance vs. Drain Current

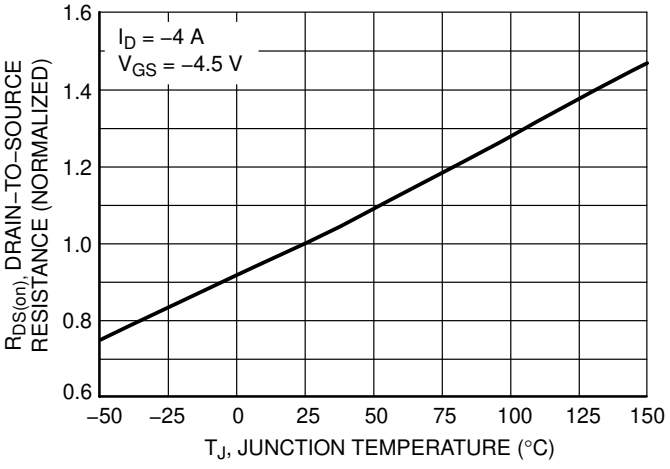


Figure 17. On−Resistance Variation with Temperature

TYPICAL P−CHANNEL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

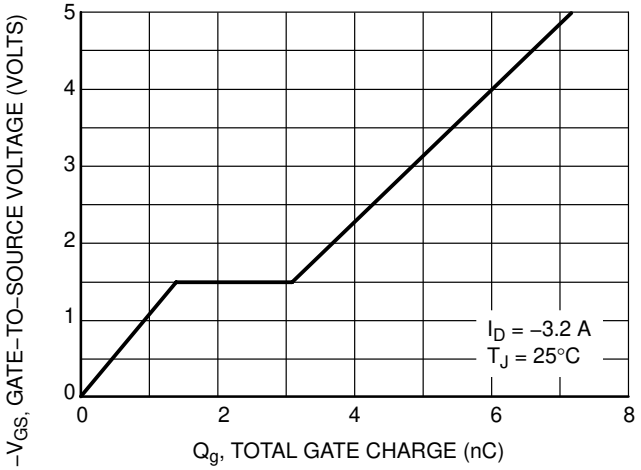


Figure 18. Gate−to−Source and Drain−to−Source Voltage vs. Total Charge

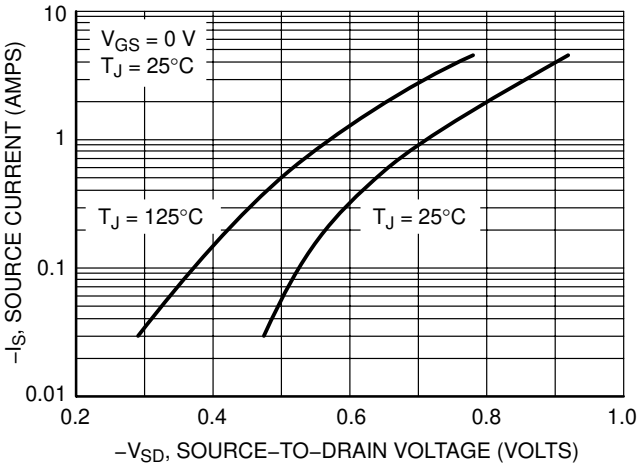


Figure 19. Diode Forward Voltage vs. Current

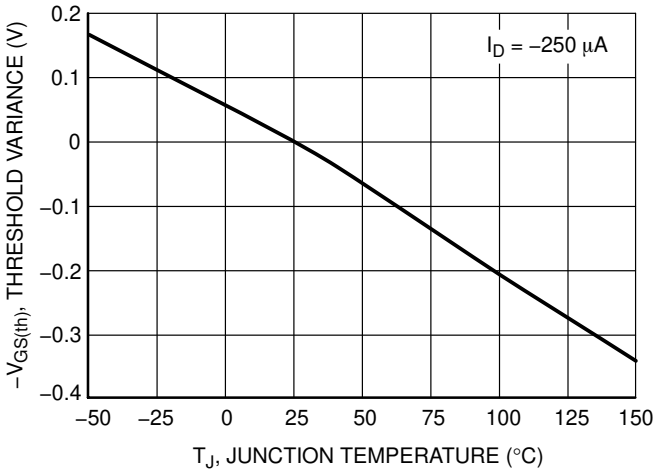


Figure 20. Threshold Voltage

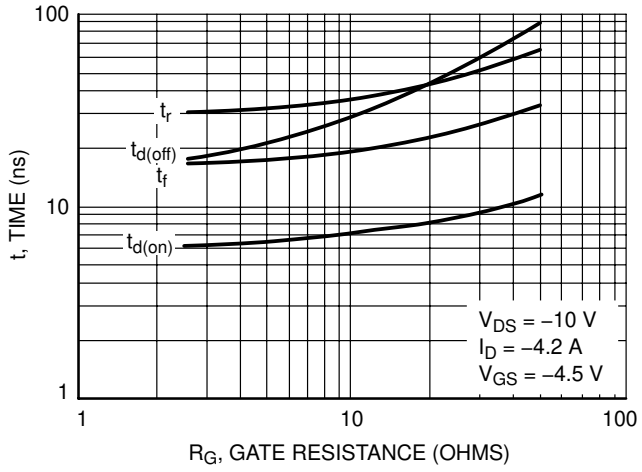


Figure 21. Resistive Switching Time Variation vs. Gate Resistance

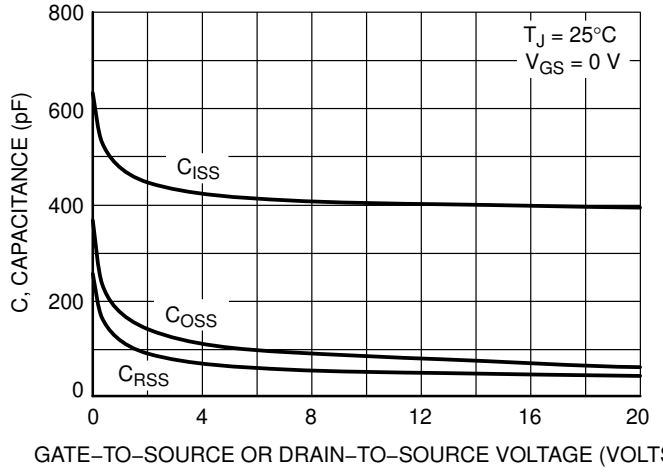


Figure 22. Capacitance Variation

TYPICAL PERFORMANCE CURVES

(T_J = 25°C unless otherwise noted)

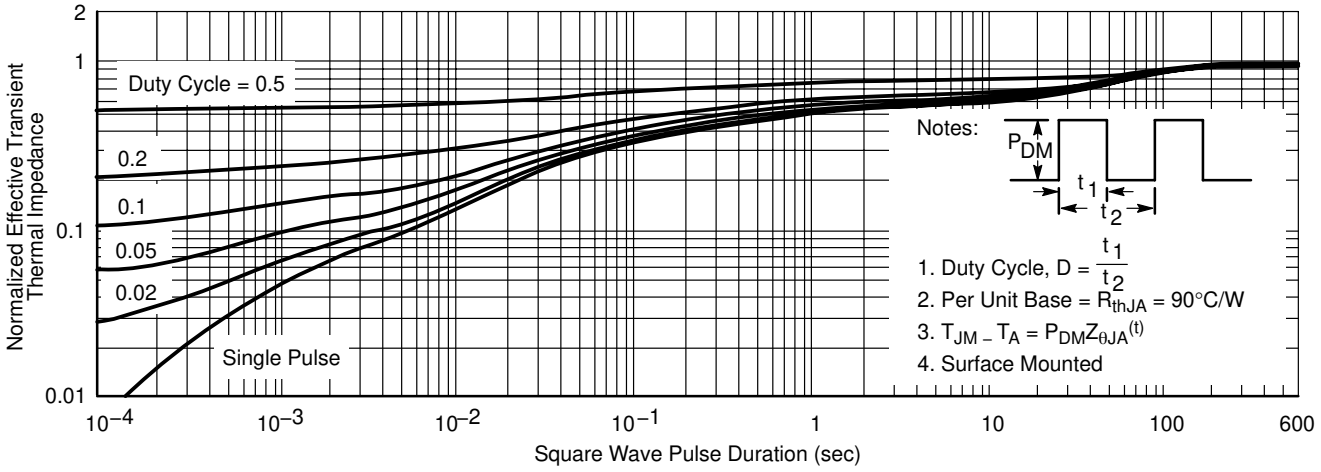


Figure 23. Thermal Response

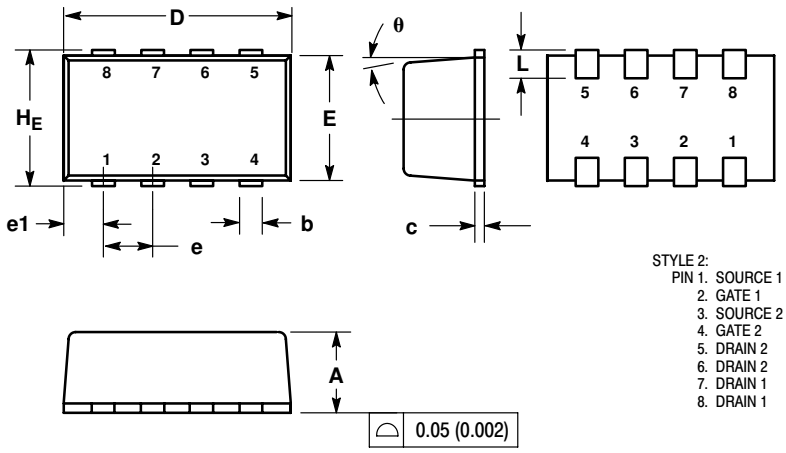
ORDERING INFORMATION

Device	Package	Shipping†
NTHD3102CT1G	ChipFET (Pb–Free)	3000 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

PACKAGE DIMENSIONS

ChipFET™
CASE 1206A–03
ISSUE G

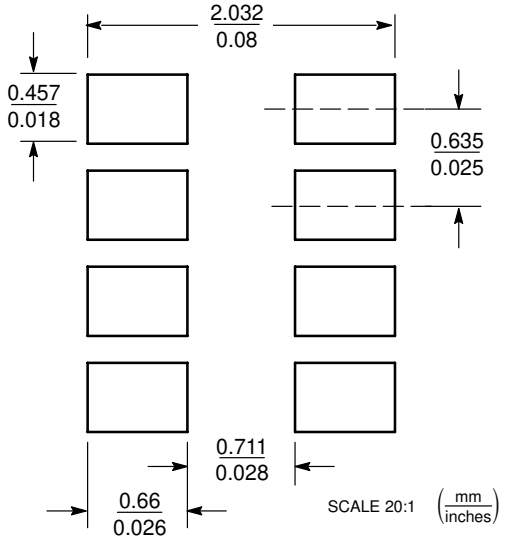


STYLE 2:
PIN 1. SOURCE 1
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. DRAIN 2
7. DRAIN 1
8. DRAIN 1

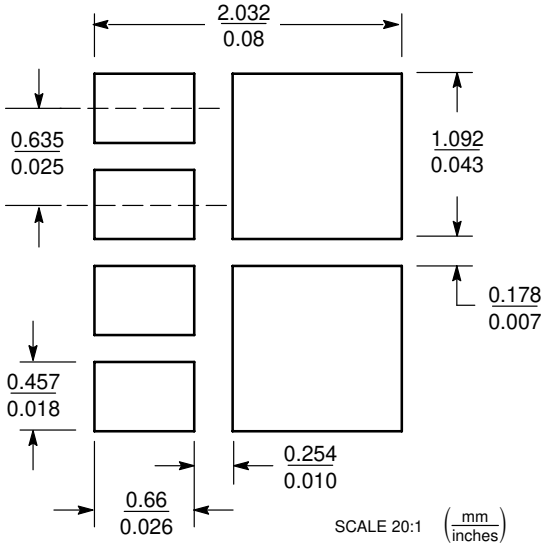
NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
A	1.00	1.05	1.10	0.039	0.041	0.043
b	0.25	0.30	0.35	0.010	0.012	0.014
c	0.10	0.15	0.20	0.004	0.006	0.008
D	2.95	3.05	3.10	0.116	0.120	0.122
E	1.55	1.65	1.70	0.061	0.065	0.067
e	0.65 BSC			0.025 BSC		
e1	0.55 BSC			0.022 BSC		
L	0.28	0.35	0.42	0.011	0.014	0.017
H_E	1.80	1.90	2.00	0.071	0.075	0.079
θ	5° NOM			5° NOM		

SOLDERING FOOTPRINT*



Basic



Style 2

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ChipFET is a trademark of Vishay Siliconix.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Literature Distribution Center for ON Semiconductor
P.O. Box 5163, Denver, Colorado 80217 USA
Phone: 303−675−2175 or 800−344−3860 Toll Free USA/Canada
Fax: 303−675−2176 or 800−344−3867 Toll Free USA/Canada
Email: orderlit@onsemi.com

N. American Technical Support: 800−282−9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81−3−5773−3850

ON Semiconductor Website: **www.onsemi.com**

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

NTHD3102C/D